

# **STF16N50U**

# N-channel 500 V, 0.47 Ω 15 A TO-220FP UltraFAST MESH™ Power MOSFET

#### **Features**

| Туре      | V <sub>DSS</sub> @<br>T <sub>jmax.</sub> | R <sub>DS(on)</sub><br>max. | I <sub>D</sub> | Pw   |
|-----------|--|-----------------------------|----------------|------|
| STF16N50U | 550 V                                    | < 0.52 Ω                    | 15 A           | 30 W |

- 100% avalanche tested
- Outstanding dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Very low R<sub>DS(on)</sub>
- Extremely low t<sub>rr</sub>

#### **Application**

- Switching applications
  - High voltage inverters specific for LCD TV
  - Lighting full bridge topology
  - Motor control

### **Description**

The device is an N-channel Ultrafast MESH<sup>TM</sup>. This technology associates all advantages of reduced on-resistance. Zener gate protection and very high dv/dt capability with an extremely enhanced fast body-drain recovery diode.

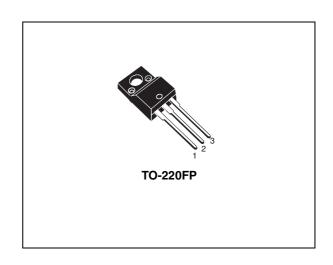


Figure 1. Internal schematic diagram

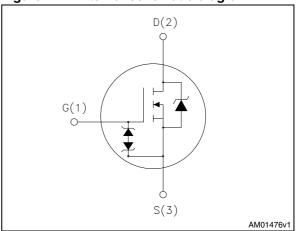


Table 1. Device summary

| Order code | Marking | Package  | Packaging |
|------------|---------|----------|-----------|
| STF16N50U  | 16N50U  | TO-220FP | Tube      |

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Contents STF16N50U

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STF16N50U Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol                         | Parameter   | Value             | Unit |
|--------------------------------|---|-------------------|------|
| V <sub>DS</sub>                | Drain-source voltage (V <sub>GS</sub> = 0)  | 500               | V    |
| V <sub>GS</sub>                | Gate-source voltage   | ± 30              | V    |
| I <sub>D</sub>                 | Drain current (continuous) at T <sub>C</sub> = 25 °C  | 15 <sup>(1)</sup> | Α    |
| I <sub>D</sub>                 | Drain current (continuous) at T <sub>C</sub> = 100 °C   | 9 (1)             | А    |
| I <sub>DM</sub> <sup>(2)</sup> | Drain current (pulsed)  | 60 <sup>(1)</sup> | Α    |
| P <sub>TOT</sub>               | Total dissipation at T <sub>C</sub> = 25 °C   | 30                | W    |
| I <sub>AR</sub>                | Avalanche current, repetitive or not-<br>repetitive (pulse width limited by $T_j$ max)              | 11                | А    |
| E <sub>AS</sub>                | Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)            | 250               | mJ   |
| dv/dt (3)                      | Peak diode recovery voltage slope   | 20                | V/ns |
| V <sub>ESD-(G-S)</sub>         | G-S EDS (HBM C=100 pF; R=1.5 kΩ)  | 4000              | V    |
| V <sub>ISO</sub>               | Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C) | 2500              | V    |
| T <sub>stg</sub>               | Storage temperature   | -55 to 150        | °C   |
| T <sub>j</sub>                 | Max. operating junction temperature 150   |                   | °C   |

<sup>1.</sup> Current is limited by wire features.

Table 3. Thermal data

| Symbol                | Parameter                                      | Value | Unit |
|-----------------------|--|-------|------|
| R <sub>thj-case</sub> | Thermal resistance junction-case max           | 3.29  | °C/W |
| R <sub>thj-amb</sub>  | Thermal resistance junction-ambient max        | 62.5  | °C/W |
| T <sub>I</sub>        | Maximum lead temperature for soldering purpose | 300   | °C   |

<sup>2.</sup> Pulse width limited by safe operating area.

<sup>3.</sup>  $I_{SD} \leq$  11 A, di/dt  $\leq$  400 A/ $\mu$ s,  $V_{DD}$  = 80%  $V_{(BR)DSS}$ .

## 2 Electrical characteristics

 $(T_C = 25 \, ^{\circ}C \text{ unless otherwise specified}).$ 

Table 4. On /off states

| Symbol               | Parameter  | Test conditions  | Min. | Тур. | Max.     | Unit                     |
|----------------------|--|--|------|------|----------|--------------------------|
| V <sub>(BR)DSS</sub> | Drain-source<br>breakdown voltage                        | I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0   | 500  |      |          | ٧                        |
| I <sub>DSS</sub>     | Zero gate voltage<br>drain current (V <sub>GS</sub> = 0) | V <sub>DS</sub> = Max rating<br>V <sub>DS</sub> = Max rating, T <sub>C</sub> =125 °C |      |      | 1<br>100 | μ <b>Α</b><br>μ <b>Α</b> |
| I <sub>GSS</sub>     | Gate-body leakage current (V <sub>DS</sub> = 0)          | V <sub>GS</sub> = ± 20 V   |      |      | ± 10     | μΑ                       |
| V <sub>GS(th)</sub>  | Gate threshold voltage                                   | $V_{DS} = V_{GS}, I_{D} = 100 \mu A$   | 3    | 3.75 | 4.5      | ٧                        |
| R <sub>DS(on</sub>   | Static drain-source on resistance                        | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A   |      | 0.47 | 0.52     | Ω                        |

Table 5. Dynamic

| Symbol   | Parameter   | Test conditions   | Min. | Тур.              | Max. | Unit           |
|--|---|---|------|-------------------|------|----------------|
| C <sub>iss</sub><br>C <sub>oss</sub><br>C <sub>rss</sub> | Input capacitance Output capacitance Reverse transfer capacitance | $V_{DS} = 25 \text{ V, f} = 1 \text{ MHz, V}_{GS} = 0$  | -    | 1950<br>250<br>59 | -    | pF<br>pF<br>pF |
| C <sub>o(tr)</sub>                                       | Equivalent capacitance time related                               | V <sub>GS</sub> = 0, V <sub>DS</sub> = 0 to 400 V   | -    | 78                | -    | pF             |
| C <sub>o(er)</sub>                                       | Equivalent capacitance energy related                             | VGS = 0, VDS = 0 to 400 V   | -    | 58                | -    | pF             |
| R <sub>G</sub>   | Intrinsic gate resistance   | f = 1 MHz open drain  | -    | 1.9               | -    | Ω              |
| Q <sub>g</sub><br>Q <sub>gs</sub><br>Q <sub>gd</sub>     | Total gate charge<br>Gate-source charge<br>Gate-drain charge      | $V_{DD} = 400 \text{ V}, I_{D} = 10 \text{ A},$<br>$V_{GS} = 10 \text{ V}$<br>(see <i>Figure 13</i> ) | -    | 40<br>7<br>22     | -    | nC<br>nC<br>nC |

Table 6. Switching times

| Symbol  | Parameter  | Test conditions  | Min. | Тур.                 | Max. | Unit                 |
|---|--|--|------|----------------------|------|----------------------|
| t <sub>d(on)</sub><br>t <sub>r</sub><br>t <sub>d(off)</sub><br>t <sub>f</sub> | Turn-on delay time Rise time Turn-off-delay time Fall time | $V_{DD} = 250 \text{ V}, I_D = 5.5 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see <i>Figure 12</i> ) | -    | 16<br>21<br>21<br>15 | -    | ns<br>ns<br>ns<br>ns |

Table 7. Source drain diode

| Symbol   | Parameter  | Test conditions   | Min. | Тур.            | Max.     | Unit          |
|--|--|---|------|-----------------|----------|---------------|
| I <sub>SD</sub>  | Source-drain current Source-drain current (pulsed)                     |   | -    |                 | 11<br>44 | A<br>A        |
| V <sub>SD</sub> (2)                                    | Forward on voltage   | I <sub>SD</sub> = 11 A, V <sub>GS</sub> = 0   | -    |                 | 1.6      | V             |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time Reverse recovery charge Reverse recovery current | I <sub>SD</sub> = 11 A, di/dt = 100 A/μs<br>V <sub>DD</sub> = 35 V (see <i>Figure 17</i> )                                    | -    | 85<br>280<br>7  |          | ns<br>nC<br>A |
| t <sub>rr</sub><br>Q <sub>rr</sub><br>I <sub>RRM</sub> | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 11 \text{ A, di/dt} = 100 \text{ A/µs}$<br>$V_{DD} = 35 \text{ V, T}_j = 150 \text{ °C}$<br>(see <i>Figure 17</i> ) | -    | 120<br>490<br>8 |          | ns<br>nC<br>A |

<sup>1.</sup> Pulse width limited by safe operating area.

Table 8. Gate-source Zener diode

| Symbol            | Parameter                     | Test conditions         | Min. | Тур. | Max. | Unit |
|-------------------|-------------------------------|-------------------------|------|------|------|------|
| BV <sub>GSO</sub> | Gate-source breakdown voltage | Igs=± 1 mA (open drain) | 30   | -    |      | ٧    |

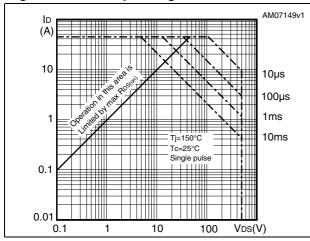
The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

<sup>2.</sup> Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%.

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



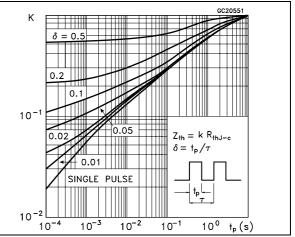
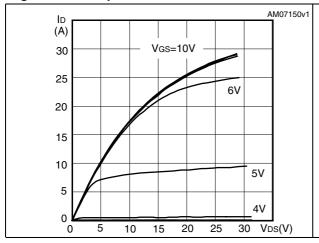


Figure 4. Output characteristics

Figure 5. Transfer characteristics



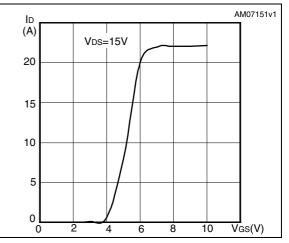
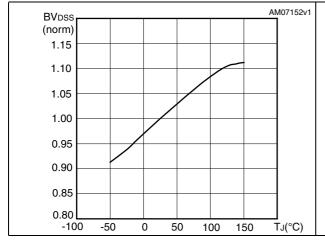
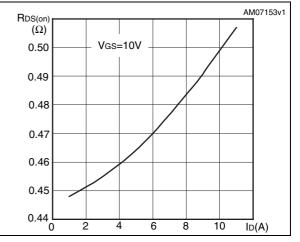


Figure 6. Normalized B<sub>VDSS</sub> vs temperature

Figure 7. Static drain-source on resistance





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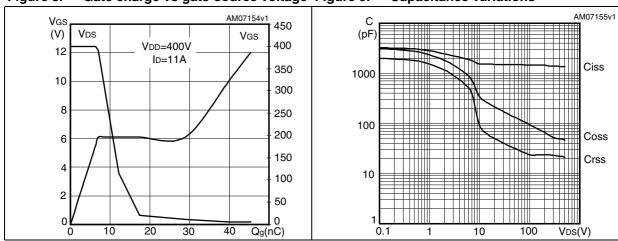
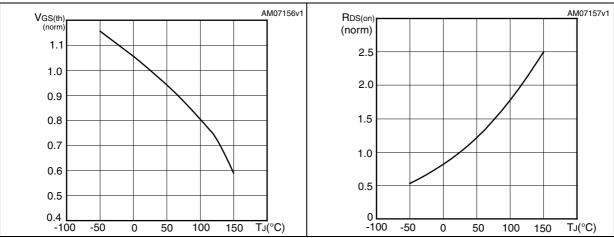


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature temperature



Test circuits STF16N50U

#### 3 Test circuits

Figure 12. Switching times test circuit for resistive load

Figure 13. Gate charge test circuit

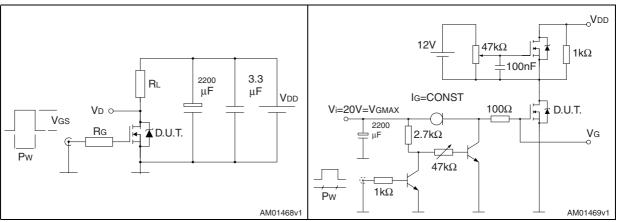


Figure 14. Test circuit for inductive load switching and diode recovery times

Figure 15. Unclamped inductive load test circuit

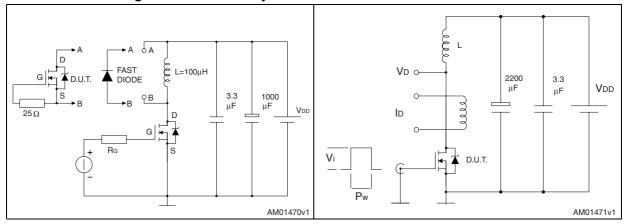
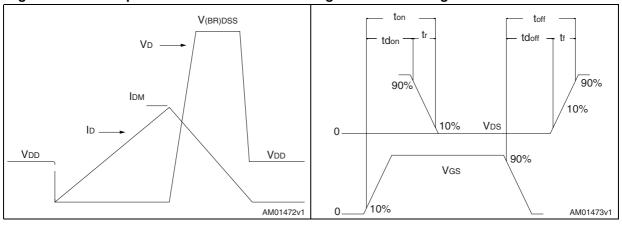


Figure 16. Unclamped inductive waveform

Figure 17. Switching time waveform



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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

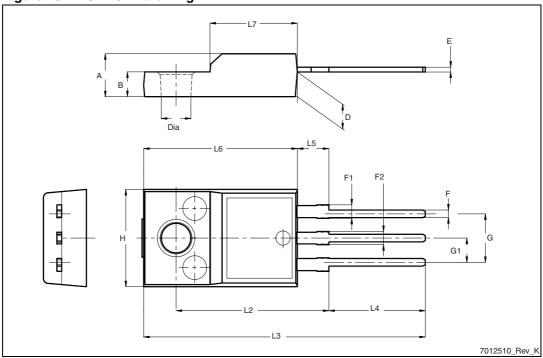
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Table 9. TO-220FP mechanical data

| Dim  |      | mm   |      |
|------|------|------|------|
| Dim. | Min. | Тур. | Max. |
| А    | 4.4  |      | 4.6  |
| В    | 2.5  |      | 2.7  |
| D    | 2.5  |      | 2.75 |
| E    | 0.45 |      | 0.7  |
| F    | 0.75 |      | 1    |
| F1   | 1.15 |      | 1.70 |
| F2   | 1.15 |      | 1.70 |
| G    | 4.95 |      | 5.2  |
| G1   | 2.4  |      | 2.7  |
| Н    | 10   |      | 10.4 |
| L2   |      | 16   |      |
| L3   | 28.6 |      | 30.6 |
| L4   | 9.8  |      | 10.6 |
| L5   | 2.9  |      | 3.6  |
| L6   | 15.9 |      | 16.4 |
| L7   | 9    |      | 9.3  |
| Dia  | 3    |      | 3.2  |

Figure 18. TO-220FP drawing



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STF16N50U Revision history

# 5 Revision history

Table 10. Document revision history

| Date        | Revision | Changes        |
|-------------|----------|----------------|
| 09-Sep-2010 | 1        | First release. |

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